


<b>Search Notes</b>  	<b>Application/Control No.</b>  10587917	<b>Applicant(s)/Patent Under Reexamination</b>  VANDEVOORDE ET AL.
	<b>Examiner</b>  Louis K Huynh	<b>Art Unit</b>  3721

SEARCHED			
Class	Subclass	Date	Examiner
53	399, 585, 291, 292, 297	6/20/2008	LH
156	86	6/20/2008	LH

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner